Atomic layer deposition appearatus for depositing atomic layer on multiple substrates

22 40 40 40 40 40 40 40 40 40 40 40 40 40	enjenence Enjenjenence Enjenjenence	eoged volume	eyal aimpia leyin
Patent Number:	US6042652		
Publication date:	2000-03-28	•	*
Inventor(s):	CHOI KANG-JUN (KR); PAF JEONG SOO-HONG (KR); Y	RK KYUNG-HO (KR); 'OON NEUNG-GOO	HYUN KWANG-SOO (KR (KR)
Applicant(s):	PKLTD(KR)	4	
Requested Patent:	□ <u>JP2000319772</u>	3	
Application Number:	US19990390710 19990907		
Priority Number(s):	KR19990015805 19990501		
IPC Classification:	C23C16/00		
EC Classification:	C23C16/44, C30B25/14		
EC Classification:	C23C16/44; C30B25/14	,	
Equivalents:		*****	
	•		

Abstract

An atomic layer deposition (ALD) apparatus capable of depositing a thin film on a plurality of substrates. The atomic layer deposition apparatus includes: a vacuum chamber, a reactor installed in the vacuum chamber, having a plurality of modules which can be assembled and disassembled as desired, a plurality of stages as spaces partitioned by assembling the plurality of modules, and openings which allow each stage to receive one substrate; a gas supply portion installed in the reactor, for supplying reaction gases and a purging gas to the reactor; and a plurality of gas supply lines installed in the modules, for injecting the gases from the gas supply portion into the stages.